

Application/Control No.	Applicant(s)/Patent under Reexamination
09/749,624	FUJIWARA ET AL.
Examiner	Art Unit
Kimbinh T. Nguyen	2671

SEARCHED				
Class	Subclass	Date	Examiner	
345	619	9/2/2005	KN	
345	620	9/2/2005	KN	
345	626	9/2/2005	KN	
345	629	9/2/2005	KN	
345	630	9/2/2005	KN	
345	631	9/2/2005	KN	
345	441	9/2/2005	KN	
345	442	9/2/2005	KN	

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
345	441	9/2/2005	KN		
345	620	9/2/2005	KN		
345	619	9/2/2005	KN		

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	DATE	EXMR
Inventor name	9/2/2005	KN
EAST: classification	9/2/2005	KN
WEST: text search	9/2/2005	KN
NPL: ACM, IEEE	9/2/2005	KN
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